

<Intelligent Power Modules>

PM35CG1B120

FLAT-BASE TYPE INSULATED PACKAGE



FEATURE

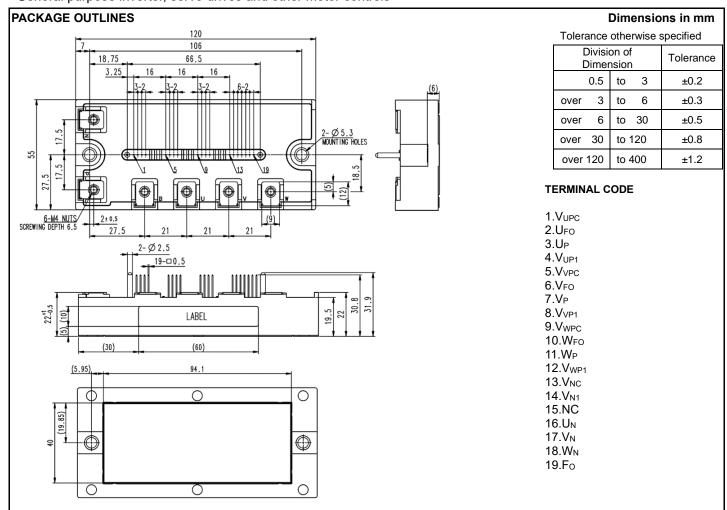
- a) Adopting Full-Gate CSTBT™ chip.
- b) The over-temperature protection which detects the chip surface temperature of CSTBT™ is adopted.
- c) Error output signal is available from each protection upper and lower arm of IPM.
- d) Outputting an error signal corresponding to the abnormal state (error mode identification)

UL Recognized under UL1557, File No. E323585
This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

APPLICATION

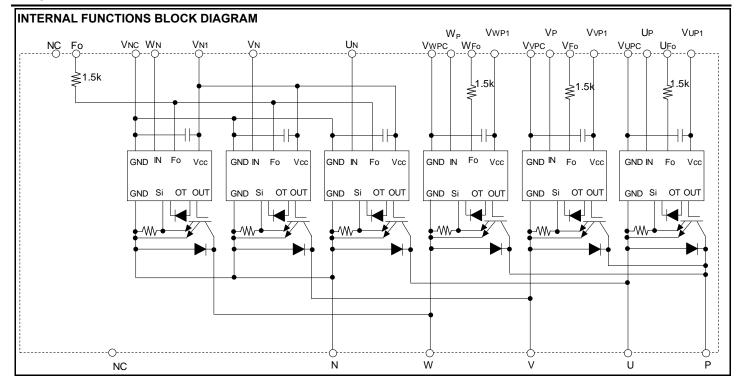
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General purpose inverter, servo drives and other motor controls



HIGH POWER SWITCHING USE

INSULATED TYPE



MAXIMUM RATINGS (Tvj = 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15 V, V _{CIN} =15 V	1200	V
Ic	Collector Current	T _C =25 °C	35	^
I _{CRM}	Collector Current	Pulse	70	A
P _{tot}	Total Power Dissipation	T _C =25 °C	290	W
l _E	Emitter Current	T _C =25 °C	35	
I _{ERM}	(Free-wheeling Diode Forward current)	Pulse	70	A
Tvj	Junction Temperature	(Note5)	-20 ~ +150	°C

^{*:} Tc measurement point is just under the chip.

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
V_D	Supply Voltage	Applied between: V _{UP1} -V _{UPC} , V _{VP1} -V _{VPC} , V _{WP1} -V _{WPC} , V _{N1} -V _{NC}	20	V
V _{CIN}	Input Voltage	Applied between: U _P -V _{UPC} , V _P -V _{VPC} , W _P -V _{WPC} , U _N , V _N , W _N -V _{NC}	20	V
V_{FO}	Fault Output Supply Voltage	Applied between: U _{FO} -V _{UPC} , V _{FO} -V _{VPC} , W _{FO} -V _{WPC} , Fo-V _{NC}	20	V
I _{FO}	Fault Output Current	Sink current at U _{FO} , V _{FO} , W _{FO} , Fo terminals	20	mA

TOTAL SYSTEM

Symbol	Parameter	Conditions	Ratings	Unit
V _{CC(PROT)}	Supply Voltage Protected by SC	V _D =13.5 V∼16.5 V, Inverter Part, Tvj=+125°C start	800	V
T_{stg}	Storage Temperature	-	-40 ~ +125	°C
T _C	Operating Case Temperature	(Note5)	-20 ~ +125	°C
V _{isol}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

^{*:} To measurement point is just under the chip.

HIGH POWER SWITCHING USE

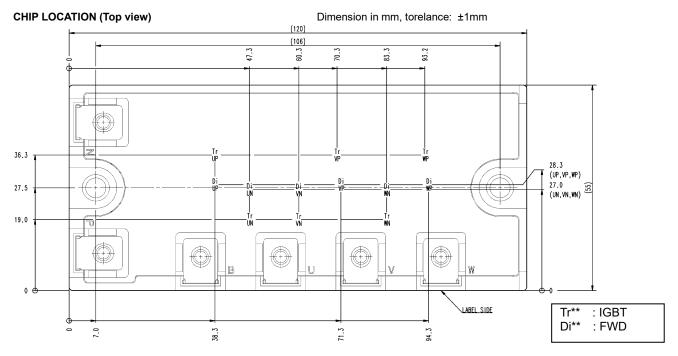
INSULATED TYPE

THERMAL RESISTANCE

Symbol	Parameter	Conditions		Limits		
Syllibol				Тур.	Max.	Unit
$R_{th(j-c)Q}$	Thermal Resistance	Junction to case, IGBT, per 1 element (Note1)	-	-	0.43	K/W
$R_{th(j-c)D}$	Thermal Resistance	Junction to case, FWD, per 1 element (Note1)	-	-	0.67	r\/vv
R _{th(c-s)}	Contact Thermal Resistance	Case to heat sink, per 1 module,	_	14.4	_	K/kW
Nth(c-s)	Contact Thermal Resistance	Thermal grease applied (Note.1, 2, 5)	-	14.4 -		IX/KVV

Note1. If you use this value, $R_{\text{th(s-a)}}$ should be measured just under the chips.

Note2. Typical value is by thermally conductive grease of λ =0.9W/(m·K), $D_{(C-S)}$ =50 μ m.



ELECTRICAL CHARACTERISTICS (Tvj= 25°C, unless otherwise noted)

INVERTER PART

Curah al	Down water	Conditions			Limits			1.1
Symbol	Parameter				Min.	Тур.	Max.	Unit
		V _D =15 V, I _C =35 A Tvj=25 °C	Terminal	-	-	1.7		
V	Collector Emitter Seturation Valtage		1 VJ=25 °C	Chip	-	1.3	-	V
V _{CEsat}	Collector-Emitter Saturation Voltage	\/ =0\/ Duland (Fig.4)	T:-405 °C	Terminal	-	-	1.95	V
		V _{CIN} =0 V, Pulsed, (Fig.1)	Tvj=125 °C	Chip	-	1.5	-	
	Emitter-Collector Voltage	V _D =15 V, I _E =35 A, Tvj=25 °	Tvi=25 °C	Terminal	-	-	2.35	V
\/			1 Vj-25 C	Chip	-	1.75	-	
V_{EC}		V _{CIN} = 15 V, pulsed, (Fig.2) Tvj=125 °C	Tvi=125 °C	Terminal	-	-	2.6	
			Chip	-	1.95	-		
ton		$V_D=15 \text{ V}, V_{CIN}=0 \text{ V} \longleftrightarrow 15 \text{ V},$		0.3	0.7	1.2		
t _{rr}		V _{CC} =600 V, I _C =35A,		-	0.13	0.4		
t _{c(on)}	Switching Time	Tvj=125 °C, Inductive Load			-	0.2	0.4	μs
t _{off}					-	1.0	2.8	
t _{c(off)}		(Fig.3, 4)			-	0.4	1.2	
	O. II t	V _{CE} =V _{CES} , V _D =15 V,		Tvj=25 °C	-	-	1	4
I _{CES}	Collector-Emitter Cut-off Current	V _{CIN} =15 V (Fig.5)		Tvj=125 °C	-	-	10	mA

HIGH POWER SWITCHING USE

INSULATED TYPE

ELECTRICAL CHARACTERISTICS (Tvj = 25°C, unless otherwise noted)

CONTROL PART

Comple al	Damanatan	Conditions		Limits			Unit
Symbol	Parameter	Conditions		Min.	Тур.	Max.	Unit
		V -15 V V -15 V	V _{P1} -V _{PC}	-	4	6	
	Circuit Current	V _D =15 V, V _{CIN} =15 V	V _{N1} -V _{NC}	-	12	18	A
I _D	Circuit Current	V _D =15 V, V _{CIN} =0 V↔15 V, V _{CC} =800 V	V _{P1} -V _{PC}	-	13	15	mA
		I _C =0A, Tvj=125 °C, f _C ≤20kHz	V _{N1} -V _{NC}	-	38	45	
$V_{th(ON)}$	Input ON Threshold Voltage	Applied between:		1.2	1.5	1.8	V
$V_{th(OFF)}$	Input OFF Threshold Voltage	U_P - V_{UPC} , V_P - V_{VPC} , W_P - V_{WPC} , U_N , V_N , W_N - V_{NC}		1.7	2.0	2.3	V
SC	Short Circuit Trip Level	-20≤Tvj≤125 °C, V _D =15 V (Fig.3, 6)		70	-	-	Α
t _{d(SC)}	Short Circuit Current Delay Time	V _D =15 V, Tvj=125 °C (Fig.3, 6)		_	2.0	-	μs
ОТ	Out Tames and the Bustonia	D	Trip level	150	-	-	°C
OT _(hys)	Over Temperature Protection	Detect temperature of IGBT chip surface	Hysteresis	-	20	-	
UV _t	Supply Circuit		Trip level	11.0	12.0	12.7	
UV _r	Under-Voltage Protection	-	Reset level	-	12.5	-	V
I _{FO(H)}	Fault Output Comment	V -45 V V -45 V (Note 2)		-	-	0.01	^
I _{FO(L)}	Fault Output Current	V _D =15 V, V _{FO} =15 V (Note3)		-	10	15	mA
			ОТ	-	8.0	-	
$t_{\sf FO}$	Fault Output Pulse Width	V _D =15 V (Note3)	UV	-	4.0	-	ms
			sc	-	2.0	-	

Note3. Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

MECHANICAL RATINGS AND CHARACTERISTICS

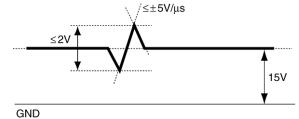
Cumbal	Parameter	Conditions		Limits		
Symbol	Falametei	Conditions	Min.	Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : Ma	2.5	3.0	3.5	N•m
Mt	Mounting Torque	Main terminal part screw : Me	1.5	1.7	2.0	INTIII
m	mass	-	-	260	-	g

RECOMMENDED CONDITIONS FOR USE

Publication date: December, 2020

Symbol	l Parameter Conditions		Recommended value	Unit
V _{CC}	Supply Voltage	Applied across P-N terminals	≤ 800	V
V _D	Control Supply Voltage	Applied between : V _{UP1} -V _{UPC} , V _{VP1} -V _{WPC} , V _{N1} -V _{NC} (Note4)	15.0±1.5	٧
V _{CIN(ON)}	Input ON Voltage	Applied between :	≤ 0.8	V
V _{CIN(OFF)}	Input OFF Voltage	$U_{P}\text{-}V_{UPC},V_{P}\text{-}V_{VPC},W_{P}\text{-}V_{WPC},U_{N},V_{N},W_{N}\text{-}V_{NC}$	≥ 9.0	\ \
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t _{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig.7)	≥ 2.5	μs

Note4. With ripple satisfying the following conditions: dv/dt swing $\leq \pm 5$ $V/\mu s$, Variation ≤ 2 V peak to peak



Note5. Long term performance related to thermal conductive material such as thermal grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition (Tvj, Tc) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

HIGH POWER SWITCHING USE

INSULATED TYPE

PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
 - After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)

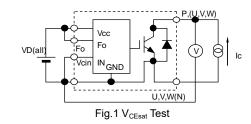
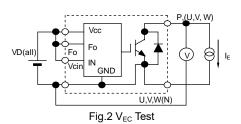


Fig.3 Switching time and SC test circuit



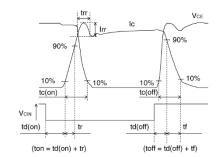


Fig.4 Switching time test waveform

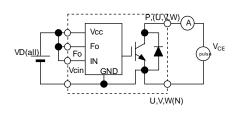


Fig.5 I_{CES} Test

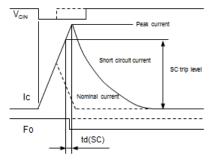
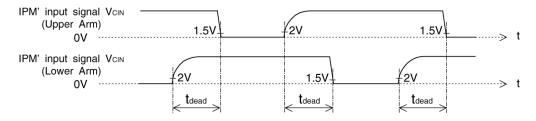


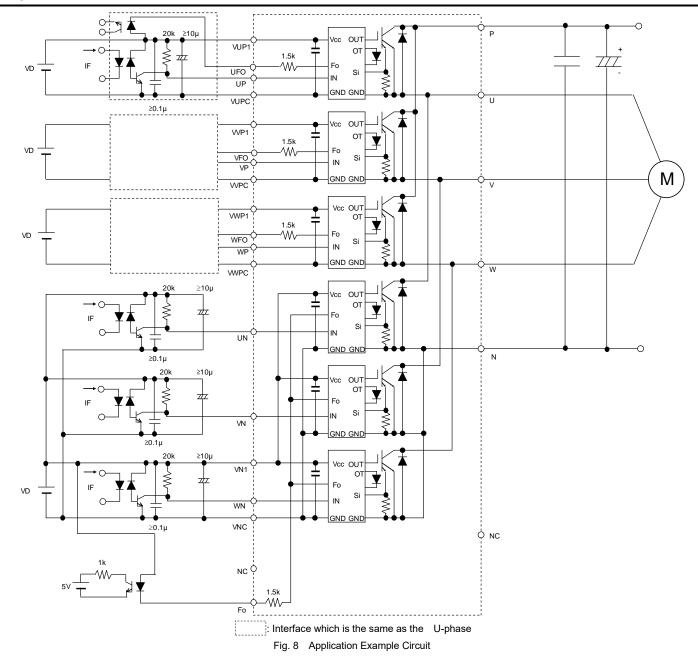
Fig.6 SC test waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value

Fig. 7 Dead time measurement point example

INSULATED TYPE

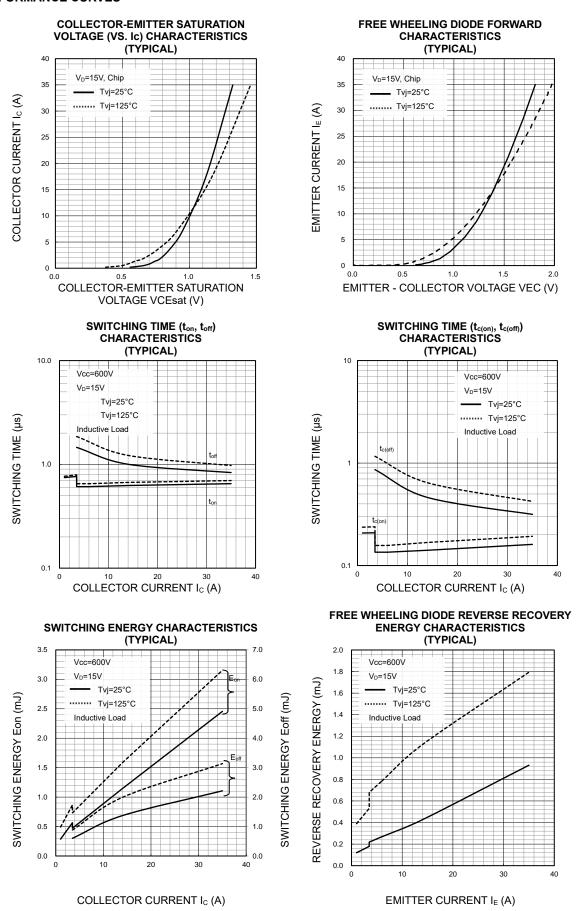


NOTES FOR STABLE AND SAFE OPERATION;

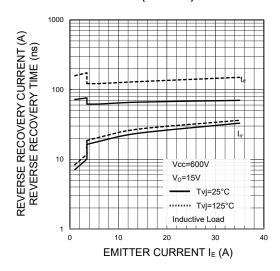
- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH}, t_{PHL} ≤ 0.8µs, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- $\bullet \ \, \text{Use 4 isolated control power supplies (V_D)}. \ \, \text{Also, care should be taken to minimize the instantaneous voltage charge of the power supply.} \\$
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

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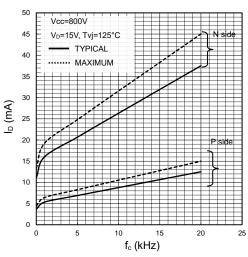
PERFORMANCE CURVES



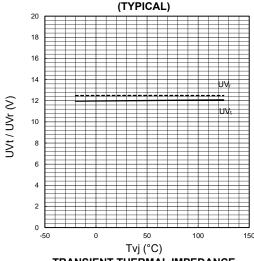
FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



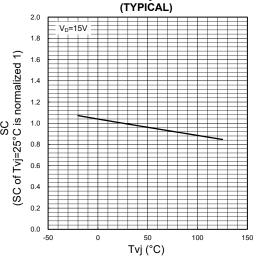
 $\begin{array}{c} \textbf{I}_{\text{D}} \ \textbf{VS.} \ \textbf{f}_{\text{C}} \ \textbf{CHARACTERISTICS} \\ \textbf{(TYPICAL, MAXIMUM)} \end{array}$



UV TRIP LEVEL VS. TVj CHARACTERISTICS



SC TRIP LEVEL VS. TVJ CHARACTERISTICS



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (TYPICAL)

	I	1	2	3	4
	Ri	0.0124	0.0739	0.3505	0.5632
	ті (sec)	1.961E-05	0.0014	0.0179	0.0944
NORMARIZED TRANSIENT THERMAL IMPEDANCE Zth(j-c)	10				
RIZED TRAN IMPEDANCI	0.1				
NORMAF	0.01	IGB Per FW	e Pulse T Part; unit base: R D Part; unit base: R		
	0.00001	0.0001 0.0		0.1	1 10
			TIME (s)		

Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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HIGH POWER SWITCHING USE INSULATED TYPE

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